

V_{DRM}	= 4400	V
V_{DSM}	= 5200	V
$I_{T(AV)M}$	= 4120	A
$I_{T(RMS)}$	= 6470	A
I_{TSM}	= 85.2×10^3	A
$V_{(T0)}$	= 1.04	V
r_T	= 0.115	m Ω

Phase Control Thyristor

5STP 52U5200

Doc. No. 5SYA1042-02 Dec. 03

- Patented free-floating silicon technology
- Low on-state and switching losses
- Designed for traction, energy and industrial applications
- Optimum power handling capability
- Interdigitated amplifying gate

Blocking

Maximum rated values ¹⁾

Symbol	Conditions	5STP 52U5200	5STP 52U5000	5STP 52U4600
V_{DSM}, V_{RSM}	$f = 5 \text{ Hz}, t_p = 10 \text{ ms}$	5200 V	5000 V	4600 V
V_{DRM}, V_{RRM}	$f = 50 \text{ Hz}, t_p = 10 \text{ ms}$	4400 V	4200 V	4000 V
V_{RSM}	$t_p = 5 \text{ ms}, \text{ single pulse}$	5700 V	5500 V	5100 V
dV/dt_{crit}	Exp. to $0.67 \times V_{DRM}, T_{vj} = 110^\circ\text{C}$	2000 V/ μs		

Characteristic values

Parameter	Symbol	Conditions	min	typ	max	Unit
Forward leakage current	I_{DSM}	$V_{DSM}, T_{vj} = 110^\circ\text{C}$			600	mA
Reverse leakage current	I_{RSM}	$V_{RSM}, T_{vj} = 110^\circ\text{C}$			600	mA

Mechanical data

Maximum rated values ¹⁾

Parameter	Symbol	Conditions	min	typ	max	Unit
Mounting force	F_M		120	135	160	kN
Acceleration	a	Device unclamped			50	m/s ²
Acceleration	a	Device clamped			100	m/s ²

Characteristic values

Parameter	Symbol	Conditions	min	typ	max	Unit
Weight	m				3.6	kg
Housing thickness	H	$F_M = 135 \text{ kN}, T_a = 25^\circ\text{C}$	34.4		35.4	mm
Surface creepage distance	D_S		56			mm
Air strike distance	D_a		22			mm

1) Maximum rated values indicate limits beyond which damage to the device may occur

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On-state

Maximum rated values ¹⁾

Parameter	Symbol	Conditions	min	typ	max	Unit
Average on-state current	$I_{T(AV)M}$	Half sine wave, $T_c = 70^\circ\text{C}$			4120	A
RMS on-state current	$I_{T(RMS)}$				6470	A
Peak non-repetitive surge current	I_{TSM}	$t_p = 10\text{ ms}$, $T_{vj} = 110^\circ\text{C}$, $V_D = V_R = 0\text{ V}$			85.2×10^3	A
Limiting load integral	I^2t				36.28×10^6	A^2s
Peak non-repetitive surge current	I_{TSM}	$t_p = 8.3\text{ ms}$, $T_{vj} = 110^\circ\text{C}$, $V_D = V_R = 0\text{ V}$			90.3×10^3	A
Limiting load integral	I^2t				33.85×10^6	A^2s

Characteristic values

Parameter	Symbol	Conditions	min	typ	max	Unit
On-state voltage	V_T	$I_T = 3000\text{ A}$, $T_{vj} = 110^\circ\text{C}$			1.38	V
Threshold voltage	$V_{(T0)}$	$I_T = 2000\text{ A} - 6000\text{ A}$, $T_{vj} = 110^\circ\text{C}$			1.04	V
Slope resistance	r_T				0.115	$\text{m}\Omega$
Holding current	I_H	$T_{vj} = 25^\circ\text{C}$			200	mA
		$T_{vj} = 110^\circ\text{C}$			100	mA
Latching current	I_L	$T_{vj} = 25^\circ\text{C}$			900	mA
		$T_{vj} = 110^\circ\text{C}$			700	mA

Switching

Maximum rated values ¹⁾

Parameter	Symbol	Conditions	min	typ	max	Unit
Critical rate of rise of on-state current	di/dt_{crit}	$T_{vj} = 110^\circ\text{C}$, $I_{TRM} = 3000\text{ A}$, Cont. $f = 50\text{ Hz}$			250	$\text{A}/\mu\text{s}$
		$V_D \leq 0.67 V_{DRM}$, $I_{FG} = 2\text{ A}$, $t_r = 0.5\ \mu\text{s}$ Cont. $f = 1\text{ Hz}$			1000	$\text{A}/\mu\text{s}$
Circuit-commutated turn-off time	t_q	$T_{vj} = 110^\circ\text{C}$, $I_{TRM} = 3000\text{ A}$, $V_R = 200\text{ V}$, $di_T/dt = -5\text{ A}/\mu\text{s}$, $V_D \leq 0.67 \cdot V_{DRM}$, $dv_D/dt = 20\text{ V}/\mu\text{s}$	700			μs

Characteristic values

Parameter	Symbol	Conditions	min	typ	max	Unit
Recovery charge	Q_{rr}	$T_{vj} = 110^\circ\text{C}$, $I_{TRM} = 3000\text{ A}$, $V_R = 200\text{ V}$, $di_T/dt = -5\text{ A}/\mu\text{s}$			12500	μAs
Gate turn-on delay time	t_{gd}	$V_D = 0.4 \cdot V_{RM}$, $I_{FG} = 2\text{ A}$, $t_r = 0.5\ \mu\text{s}$, $T_{vj} = 25^\circ\text{C}$			3	μs

Triggering

Maximum rated values ¹⁾

Parameter	Symbol	Conditions	min	typ	max	Unit
Peak forward gate voltage	V_{FGM}				12	V
Peak forward gate current	I_{FGM}				10	A
Peak reverse gate voltage	V_{RGM}				10	V
Average gate power loss	$P_{G(AV)}$		see Fig. 9			

Characteristic values

Parameter	Symbol	Conditions	min	typ	max	Unit
Gate-trigger voltage	V_{GT}	$T_{vj} = 25\text{ °C}$			2.6	V
Gate-trigger current	I_{GT}	$T_{vj} = 25\text{ °C}$			400	mA
Gate non-trigger voltage	V_{GD}	$V_D = 0.4 \times V_{DRM}, T_{vj} = 110\text{ °C}$	0.3			V
Gate non-trigger current	I_{GD}	$V_D = 0.4 \times V_{DRM}, T_{vj} = 110\text{ °C}$	10			mA

Thermal

Maximum rated values ¹⁾

Parameter	Symbol	Conditions	min	typ	max	Unit
Operating junction temperature range	T_{vj}				110	°C
Storage temperature range	T_{stg}		-40		140	°C

Characteristic values

Parameter	Symbol	Conditions	min	typ	max	Unit
Thermal resistance junction to case	$R_{th(j-c)}$	Double-side cooled $F_m = 120...160\text{ kN}$			4	K/kW
	$R_{th(j-c)A}$	Anode-side cooled $F_m = 120...160\text{ kN}$			8	K/kW
	$R_{th(j-c)C}$	Cathode-side cooled $F_m = 120...160\text{ kN}$			8	K/kW
Thermal resistance case to heatsink	$R_{th(c-h)}$	Double-side cooled $F_m = 120...160\text{ kN}$			0.8	K/kW
	$R_{th(c-h)}$	Single-side cooled $F_m = 120...160\text{ kN}$			1.6	K/kW

Analytical function for transient thermal impedance:

$$Z_{th(j-c)}(t) = \sum_{i=1}^n R_{th i} (1 - e^{-t/\tau_i})$$

i	1	2	3	4
$R_{th i}(\text{K/kW})$	2.701	0.816	0.326	0.160
$\tau_i(\text{s})$	0.9478	0.1249	0.0146	0.0032

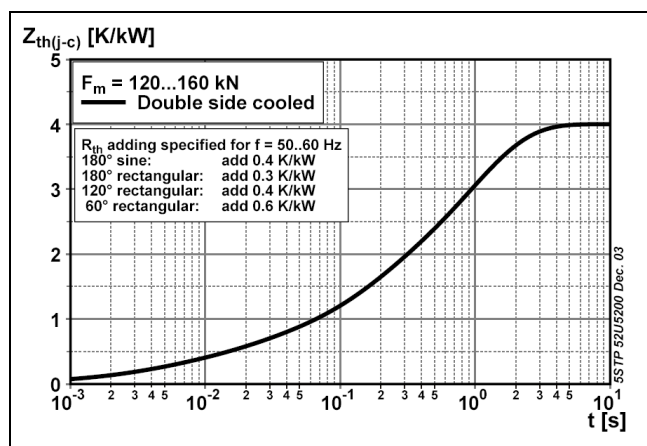


Fig. 1 Transient thermal impedance junction-to case.

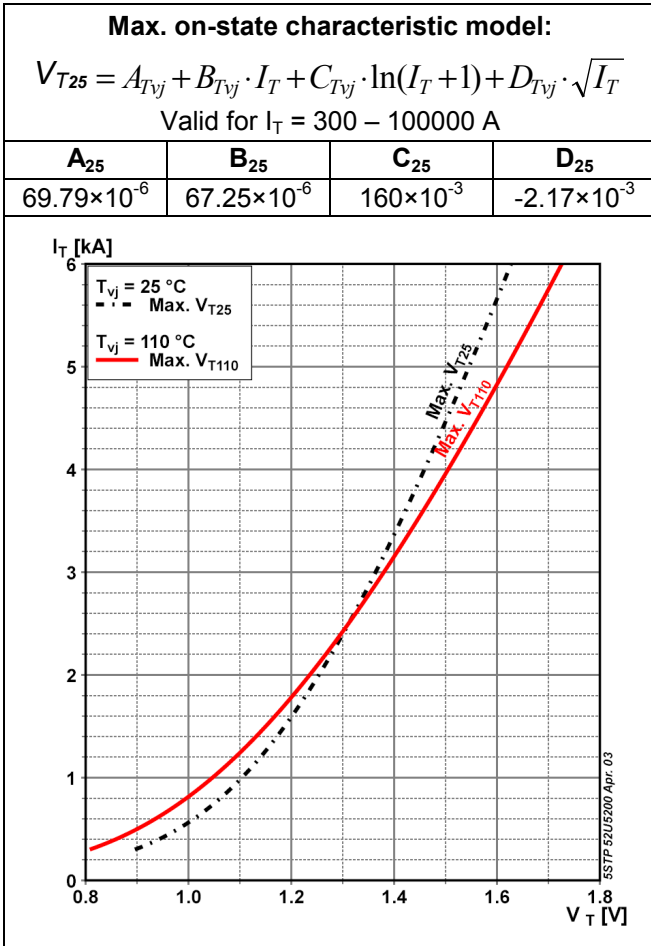


Fig. 2 Max. on-state voltage characteristics

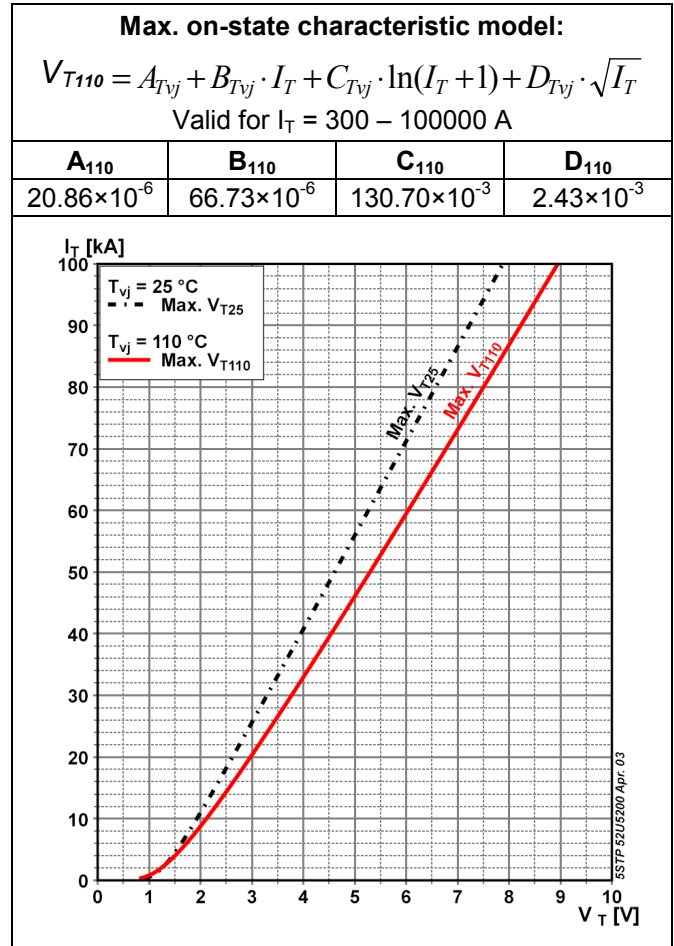


Fig. 3 Max. on-state voltage characteristics

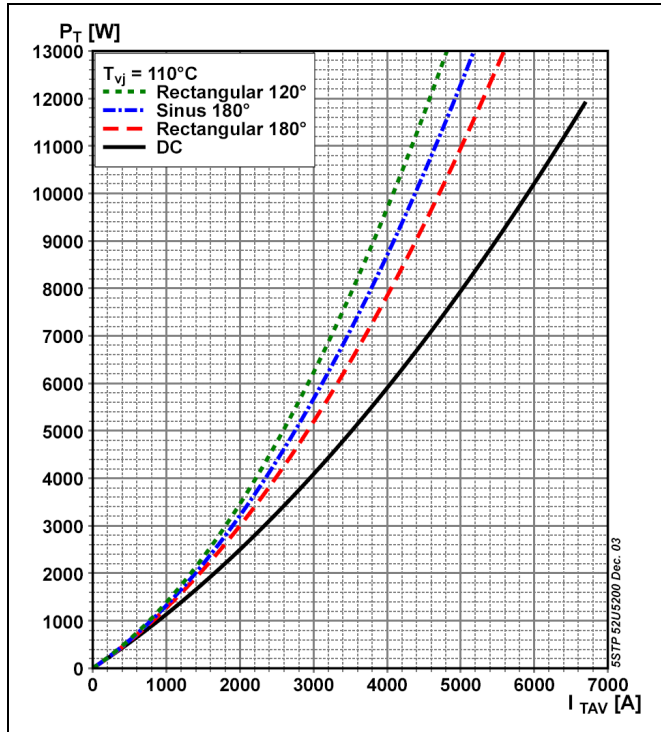


Fig. 4 On-state power dissipation vs. mean on-state current. Turn-on losses excluded.

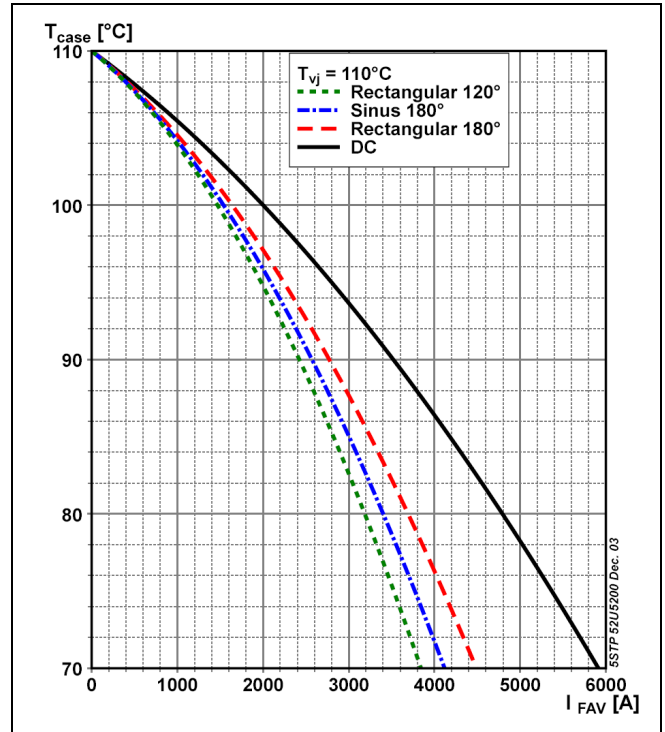


Fig. 5 Max. permissible case temperature vs. mean on-state current.

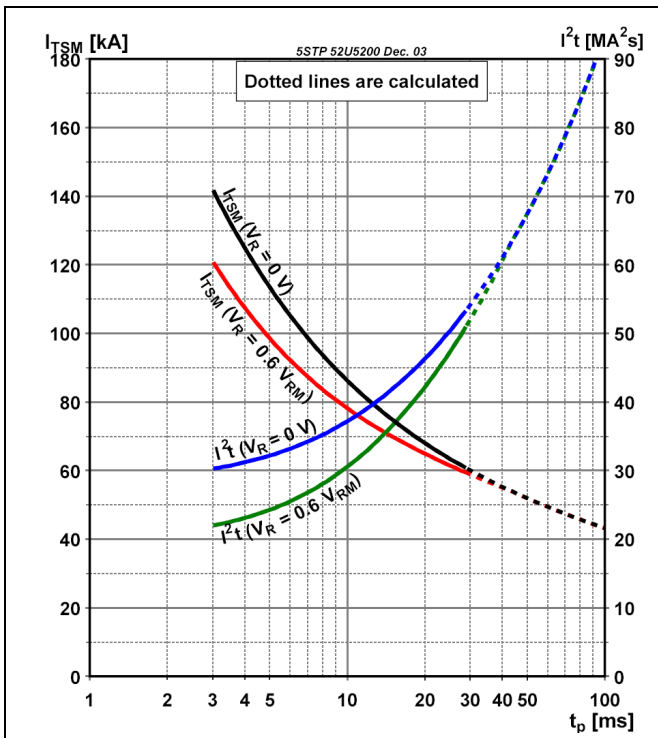


Fig. 6 Surge on-state current vs. pulse length. Half-sine wave.

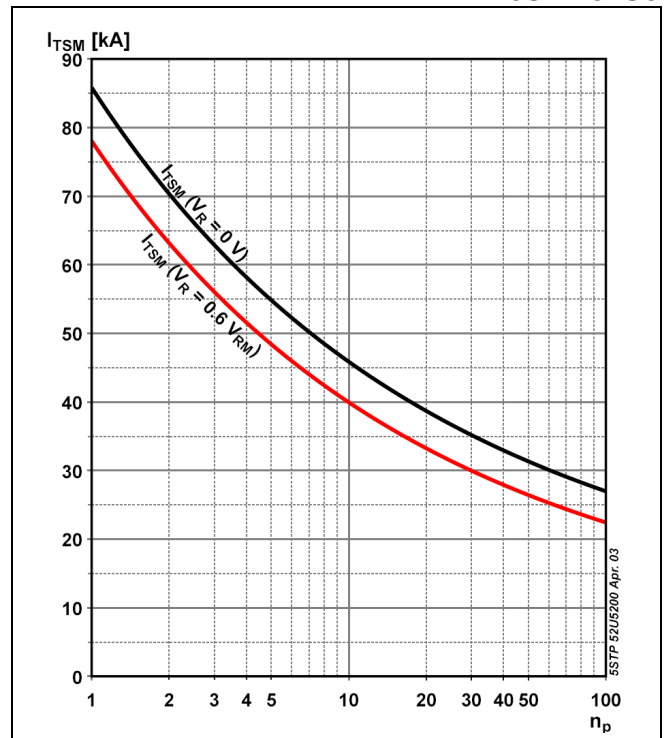


Fig. 7 Surge on-state current vs. number of pulses. Half-sine wave, 10 ms, 50Hz.

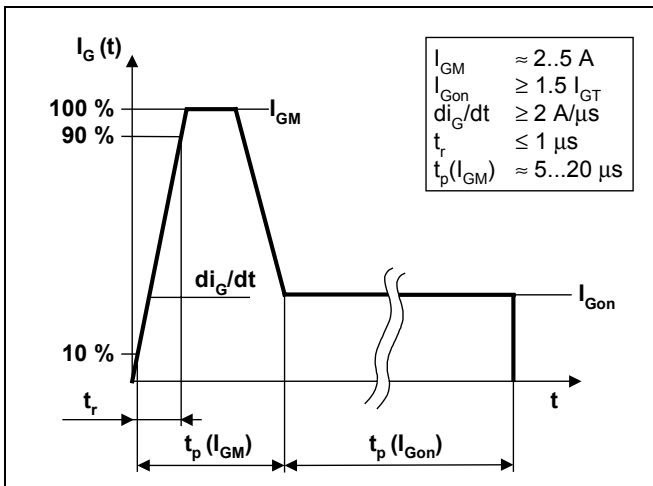


Fig. 8 Recommended gate current waveform.

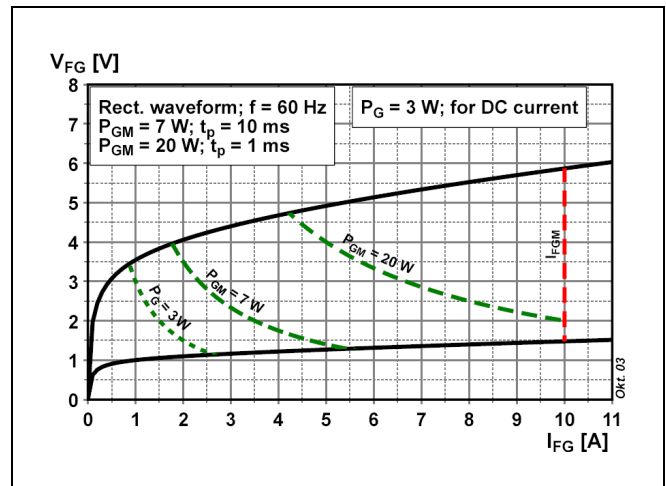


Fig. 9 Max. peak gate power loss.

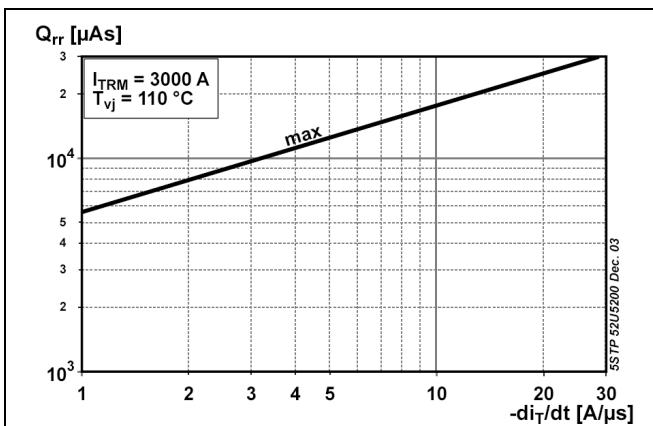


Fig. 10 Recovery charge vs. decay rate of on-state current.

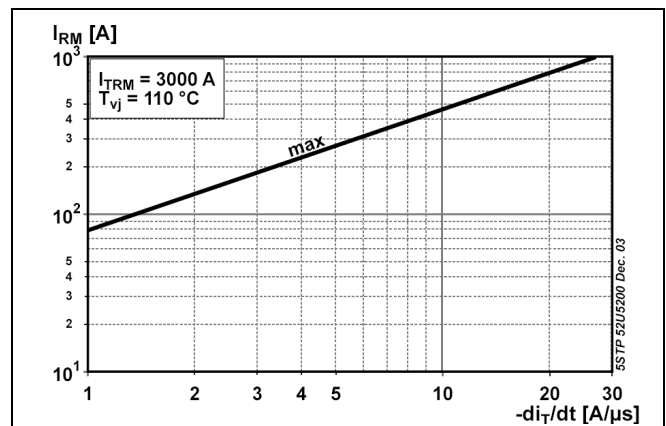


Fig. 11 Peak reverse recovery current vs. decay rate of on-state current.

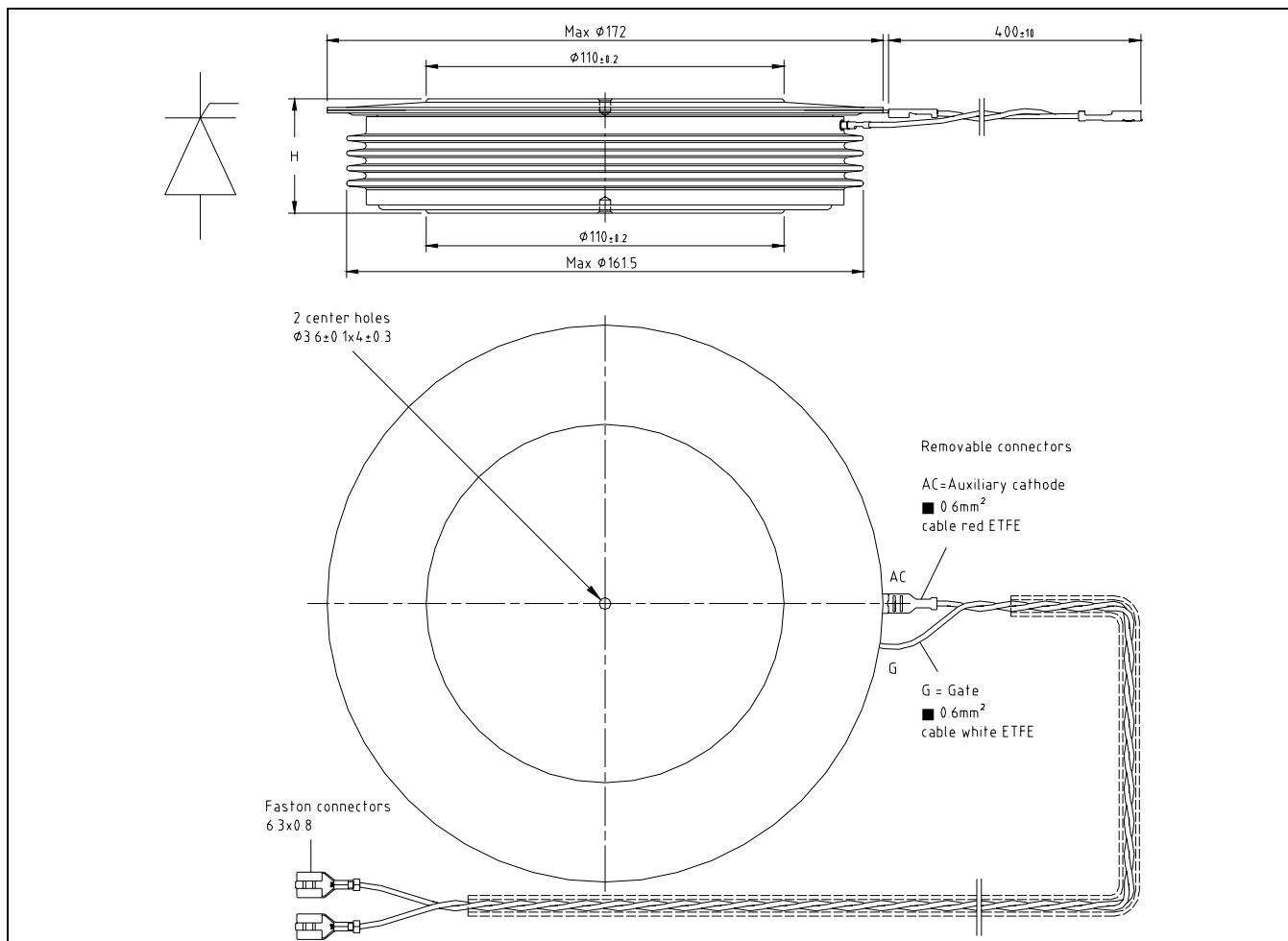


Fig. 12 Device Outline Drawing.

Related application notes:

Doc. Nr	Titel
5SYA2020	Design of RC-Snubber for Phase Control Applications
5SYA2034	Gate-drive Recommendations for PCT's
5SYA 2036	Recommendations regarding mechanical clamping of Press Pack High Power Semiconductors

Please refer to <http://www.abb.com/semiconductors> for actual versions.

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